Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/783,250	PAL ET AL.
Examiner	Art Unit
Chuck Kendall	2192

	SEARCHED					
Class	Subclass	Date	Examiner			
717	124-137	6/2/2005	ск			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Consult Wei, XP 2122	4/19/2005	ск			
East Search (USPGPUB,IBM,DERWENT,JPO,EP O, USPATENT)	6/2/2005	ск			
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